

## 30V N-Channel MOS

### Description

The NP60N03QR uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge.

### General Features

- ◆  $V_{DS} = 30V$ ,  $I_D = 60A$   
 $R_{DS(ON)}(Typ.) = 4\ m\Omega$  @  $V_{GS} = 10V$   
 $R_{DS(ON)}(Typ.) = 6.3\ m\Omega$  @  $V_{GS} = 4.5V$   
 High power and current handling capability
- ◆ Lead free product is acquired
- ◆ Surface mount package

### Application

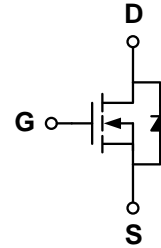
- ◆ High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- ◆ Networking DC-DC Power System
- ◆ Load switch

### Package

- ◆ DFN3×3-8L



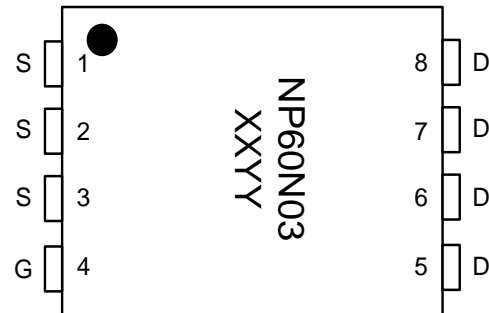
### Schematic diagram



### Marking and pin assignment

**DFN3×3-8L**

(Top View)



### Ordering Information

Part Number	Storage Temperature	Package	Devices Per Reel
NP60N03QR-G	-55°C to +150°C	DFN3×3-8L	5000

### Absolute Maximum Ratings (TA=25°C unless otherwise noted)

parameter	symbol	limit	unit	
Drain-source voltage	$V_{DS}$	30	V	
Gate-source voltage	$V_{GS}$	±20	V	
Continuous Drain Current	$I_D$	TC=25°C	60	A
		TC=100°C	45	
Pulsed Drain Current	$I_{DP}$	180	A	
Avalanche Current	IAS	48	A	
Avalanche energy( L=0.5mH)	EAS	120	mJ	
Maximum power dissipation	$P_D$	TC=25°C	28	W
Power Dissipation – Derate above 25°C		TC=25°C	1.67	
Operating junction Temperature range	$T_j$	-55—150	°C	

**Electrical Characteristics** (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
Drain-source breakdown voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	30	-	-	V
BVDSS Temperature Coefficient	ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Reference to 25°C, I <sub>D</sub> =1mA	-	27	-	mV/°C
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V	-	-	1	μA
		T <sub>J</sub> =85°C	-	-	30	
Gate Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V	-	-	±100	nA
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0	1.6	2.5	V
Drain-source on-state resistance <sup>1</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	4	4.5	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A	-	6.3	8	
On Status Drain Current	I <sub>D(ON)</sub>	V <sub>DS</sub> =10V, V <sub>GS</sub> =10V	40	-	-	A
<b>Diode Characteristics</b>						
Diode Forward Voltage <sup>1</sup>	V <sub>SD</sub>	I <sub>SD</sub> =1A, V <sub>GS</sub> =0V	-	0.8	1.1	V
Diode Continuous Forward Current	I <sub>S</sub>		-	-	60	A
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =30A,	-	9.2	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	dI/dt=100A/us	-	2	-	nC
<b>Dynamic Characteristics<sup>2</sup></b>						
Gate Resistance	R <sub>G</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	-	1.7	-	Ω
Input capacitance	C <sub>ISS</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V f=1.0MHz	-	2161	-	pF
Output capacitance	C <sub>OSS</sub>		-	308	-	
Reverse transfer capacitance	C <sub>RSS</sub>		-	261	-	
Turn-on delay time	t <sub>D(ON)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =20Ω, I <sub>D</sub> =20A, R <sub>G</sub> =3.3Ω	-	4.6	-	ns
Turn-on Rise time	t <sub>r</sub>		-	12.2	-	
Turn-off delay time	t <sub>D(OFF)</sub>		-	26.6	-	
Turn-off Fall time	t <sub>f</sub>		-	8	-	
Total gate charge	Q <sub>g</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A V <sub>DS</sub> =15V	-	42.3	-	nC
Gate-source charge	Q <sub>gs</sub>		-	6.7	-	
Gate-drain charge	Q <sub>gd</sub>		-	8.6	-	
<b>Drain-Source Diode Characteristics</b>						
Diode forward voltage	V <sub>SD</sub>	I <sub>SD</sub> =1A, V <sub>GS</sub> =0V	-	0.8	1.1	V

Note: 1: Pulse test; pulse width ≤ 300ns, duty cycle ≤ 2%.

2: Guaranteed by design, not subject to production testing.

**Thermal Characteristics**

Parameter	Symbol	Typical	Unit
Thermal Resistance-Junction to Case	Rθjc	1.7	°C/W
Thermal Resistance junction-to ambient	Rθja	62.5	

## Typical Performance Characteristics

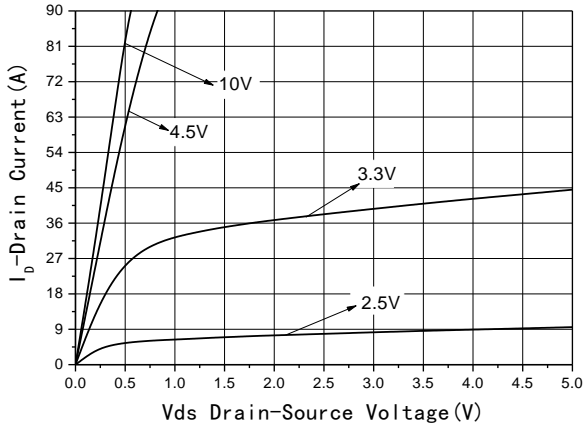


Fig1 Output Characteristics

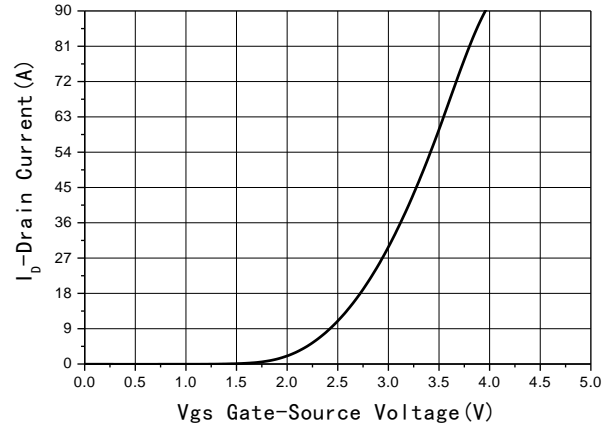


Fig2 Transfer Characteristics

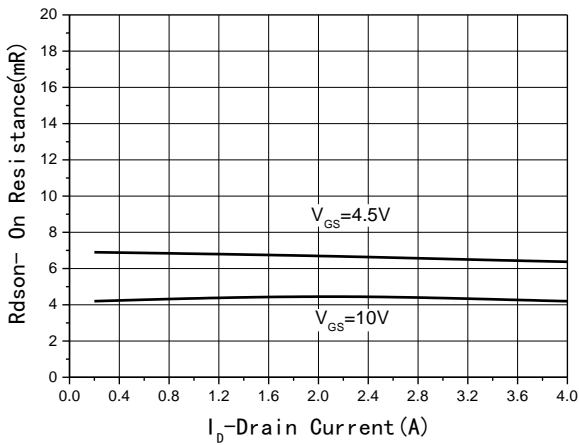


Fig3  $R_{DS(on)}$ -Drain current

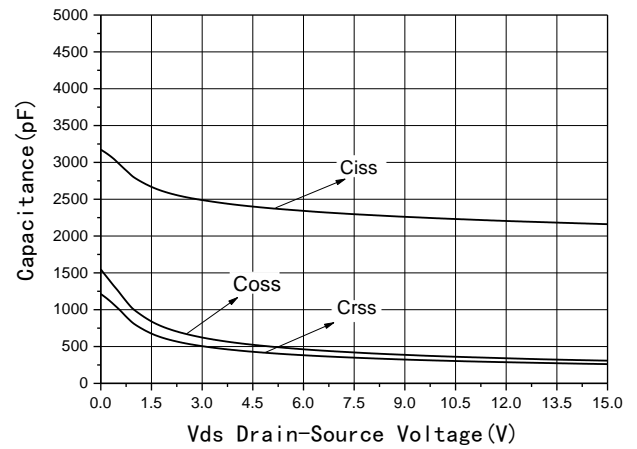


Fig4 Capacitance vs  $V_{DS}$

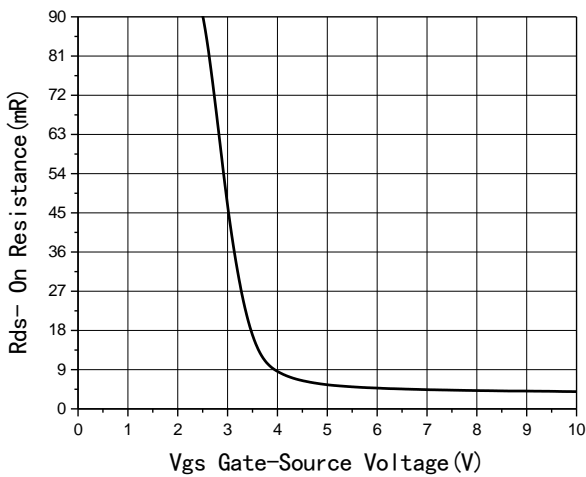


Fig5  $R_{DS(on)}$ -Gate Drain voltage

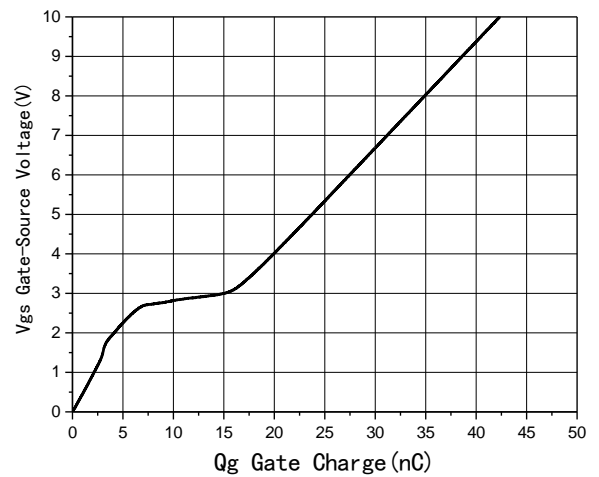
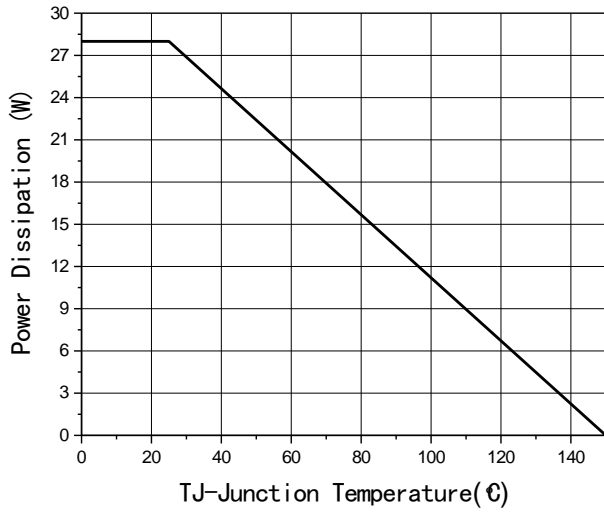
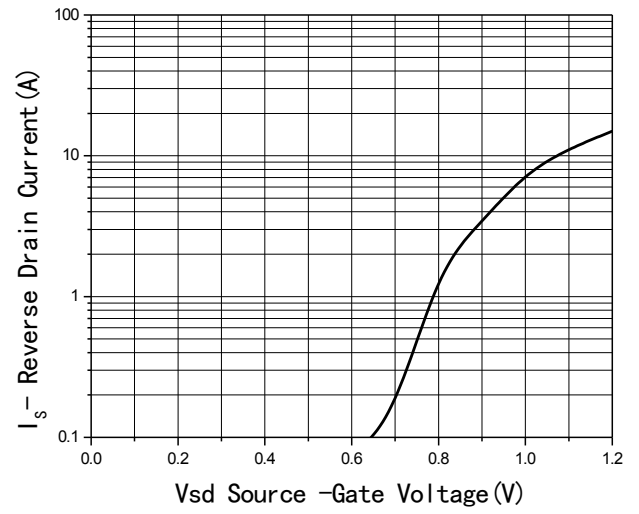


Fig6 Gate Charge



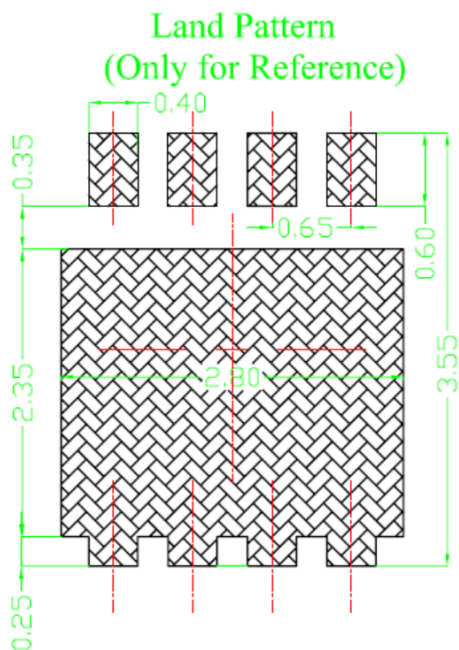
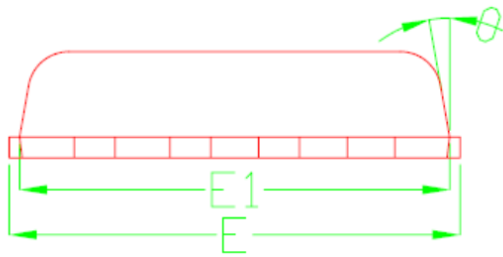
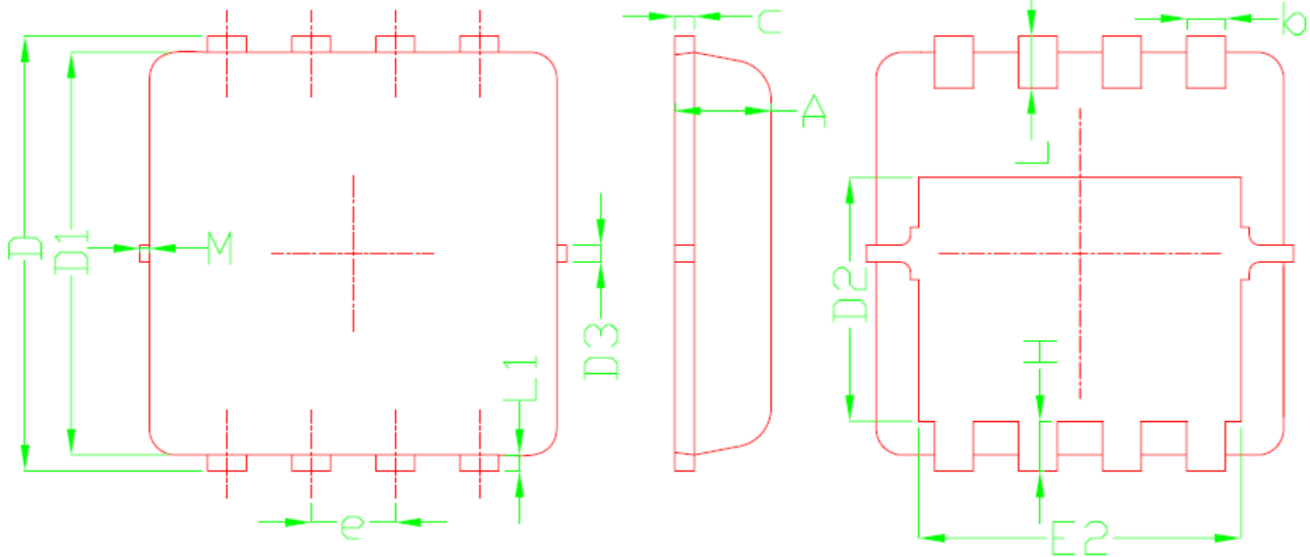
**Fig7 Power De-rating**



**Fig8 Source-Drain Diode Forward**

## Package Information

- DFN3×3-8L



SYMBOL	DIMENSIONAL REQMTS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
b	0.25	0.30	0.35
c	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.78	1.88	1.98
D3	---	0.13	---
E	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
e	0.65BSC		
H	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	---	0.13	---
$\theta$	---	10°	12°
M	*	*	0.15
* Not specified			